Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10770295	CHANG ET AL.	
Examiner	Art Unit	
Bétit, Jacob F	2164	

SEARCHED				
Class	Subclass	Date	Examine	

SEARCH NOTES					
Search Notes	Date	Examiner			
updated search	6/11/07	JFB			

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		